

## The Most Accurate Atomic Force Microscope

# Park NX-PTR

Fully Automated AFM for Accurate Inline Metrology of Hard Disk Head Sliders







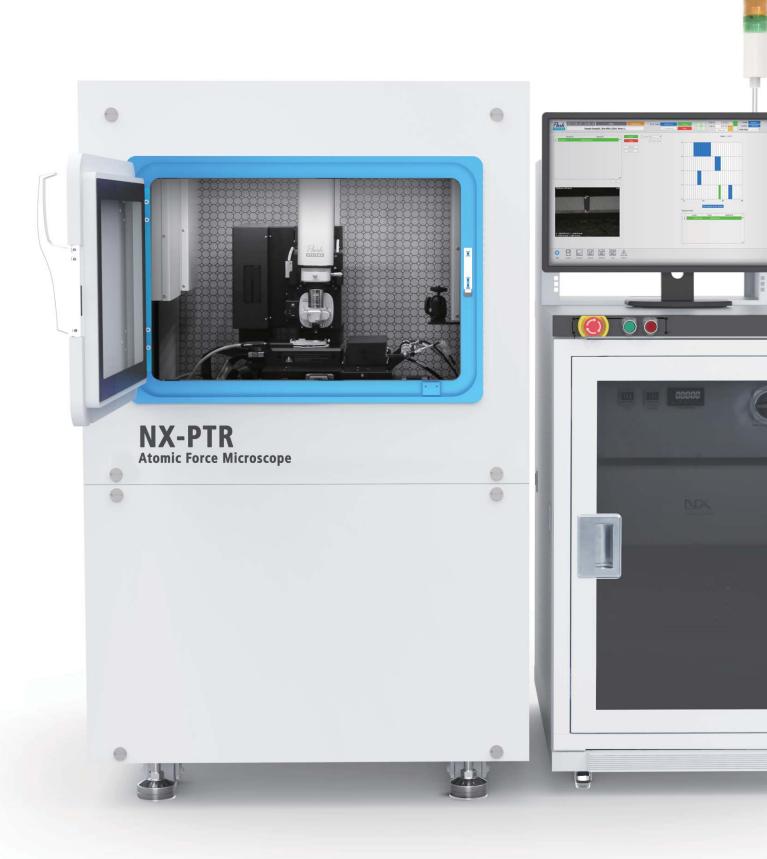
The only automated AFM for inline PTR measurement

# Inline Automation, for Fast, Accurate, and Repeatable PTR Measurements

The hard disk drive slider manufacturing industry demands a tool that provides fast, streamlined Pole Tip Recession Measurements while still maintaining the highest standard of accuracy available. It demands a tool like the Park NX-PTR. The NX-PTR offers extremely accurate PTR measurements to process engineers with inline automation that increases throughput. This makes it the perfect solution for HDD slider manufacturers looking to maximize their quality and production yield.

# High Throughput, with No Need for Multiple Reference Scans

Most AFMs require multiple scans to get accurate PTR measurements - First macroscale reference scans then high-resolution scans of smaller areas of interest. This multi-scan process takes time and limits throughput. Our crosstalk eliminated scan system allows for truly flat scans, effectively eliminating the multi-scan process. In addition, True Non-Contact™ Mode preserves tip sharpness for prolonged high resolution imaging and much longer tip life. This lets the Park NX-PTR generate accurate images of highly detailed regions of interest within larger macrostructures, without any need of reference scan to correct various scanner artifacts.



# Powerful features for high throughput inline PTR measurements

# Be more productive with Fully Automated AFM for Inline Hard Disk Slider Metrology

- Automated PTR imaging in non-contact mode
- Automated analysis of PTR images for carrier, rowbar, or individual slider
- Automatic tip exchange (optional)
- Industry's lowest system noise of less than 0.5 Å rms

# Accurate and Repeatable Measurements for Improved Production Yield

- Accurate imaging of HDD sliders without any need of larger sized reference scans
- Accurate height and angle measurements for industry leading PTR gauge repeatability
- Flat and orthogonal XY scan removes artifacts from background curvature
- Superior tool-to-tool matching

### **Accurate Height Measurements with Low Noise Z Detector**

- True Sample Topography™ without edge overshoot or piezo creep error
- Accurate surface height recording, even during high-speed scanning
- Industry leading forward and backward scan gap of less than 0.15%

## Best Tip Life and Scan Resolution by True Non-Contact™ Mode

- 10 times or longer tip life during PTR measurements than any other AFMs
- Minimal tip wear from prolonged high-quality scans
- Minimized sample damage or modification

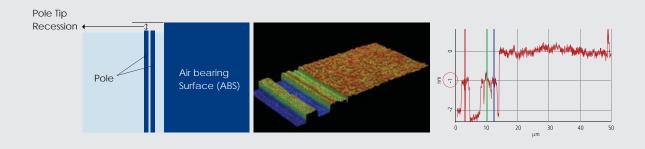
## **Productivity meets Accuracy**

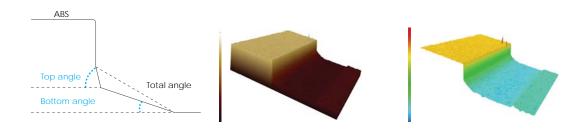
### **Automated Inline Measurements of Hard Disk Sliders**

The key to improving the production yield of hard disk sliders with shrinking dimensions and increasing complexity is accuracy at the nanoscale. Park NX-PTR provides accurate, automatic measurements for hard disk sliders.

#### **Automatic PTR Measurement and Analysis**

Pole Tip Recession measurements are fully automated with the NX-PTR system, giving you higher throughput capability, both at the carrier, rowbar, and slider level.



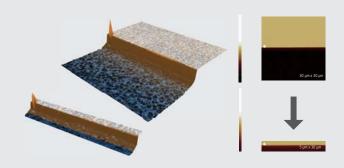


#### **Automatic Wall Angle Measurement & Analysis**

Automatically get measurement and analysis of the various wall angle applications.

## **Automatic Defect Measurement and Analysis**

Measurement and analysis of various defects such as edge spikes are fully automated.



## **Automatic Tip Exchange**

Park's automatic tip exchange system lets you seamlessly continue automated measurement routines. It automatically calibrates cantilever location and optimizes measurement settings based on measurements of a reference pattern. Our novel magnetic approach to the tip exchange has a 99% success rate, so you can do better work with less oversight.

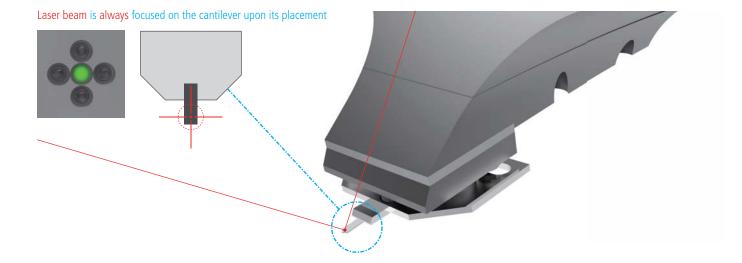




## **Automatic Laser Beam Alignment**

Park's automatic laser beam alignment lets the user seamlessly continue automated measurement routines without user input. With our advanced pre-aligned cantilever holder, the laser beam is focused on the cantilever upon automatic tip exchange. The laser spot is then optimized along the X- and Y-axis by motorized positioning knobs.



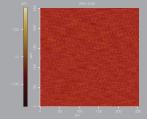


## **Powerful and yet reliable AFM**

#### **Industry's Lowest Noise Floor**

To detect the smallest sample features, and image the flattest surfaces, Park has engineered to achieve the industry's lowest noise floor specification of < 0.5 Å. The noise floor data is determined using a "zero scan." The system noise is measured with the cantilever in contact on the sample surface at a single point under the following conditions:

- 0 nm x 0 nm scan, staying at one point.
- 0.5 gain in contact mode
- 256 x 256 pixels

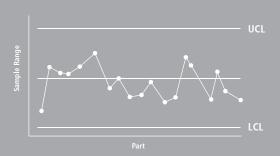


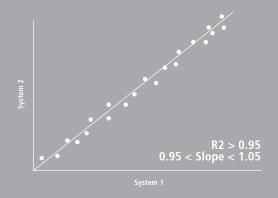
## Typically 0.3 Å rms or lower

Statistics					
Region	Mid(pm)	Mean(pm)	Rpv(pm)	Rq(pm)	Ra(pm)
<b>∠</b> Red	0.000	-0.011	359,496	30,025	19,177

### Gauge Repeatability and Reproducibility

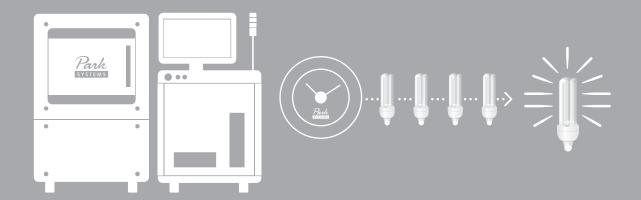
Due to the ever-decreasing size of components, manufacturers now require the highest level of quality control. Park AFM can provide 1 gauge sigma of less than 1 angstrom.





#### **Tool-to-tool Correlation**

Thanks to Park's revolutionary AFM platform that was designed for industrial metrology, Park NX-PTR will correlate with any existing Park AFMs that have been previously used for manufacturing, inspection, analysis, or research.



### **System Uptime**

Our engineers and scientists have adopted the most rigorous industry standard product development to ensure the highest level of system reliability. Park NX-PTR can be incorporated seamlessly either as an inline or as an offline inspection tool, with minimal maintenance requirements.



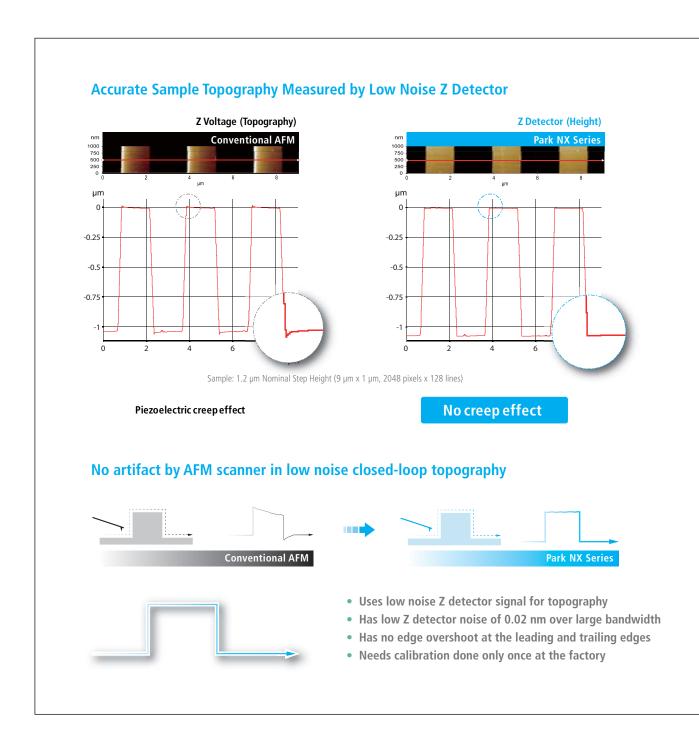
#### **Service and Maintenance**

Park is committed to the highest level of service and support. We put every effort to understand our customers' needs. We place the highest priority in meeting promised delivery dates, guaranteed quality, and thorough after-sales service.

# Park NX-PTR Park AFM technology

## **Industry Leading Low Noise Z Detector**

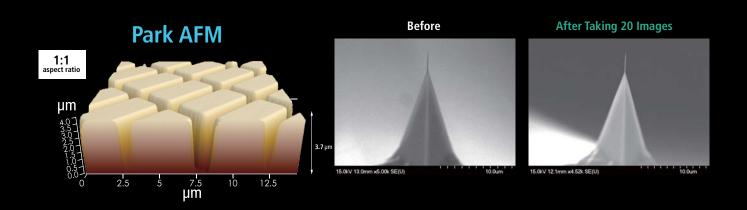
Our AFMs are equipped with the most effective low noise Z detectors in the field, with a noise of 0.2 Å over large bandwidth. This produces highly accurate sample topography, no edge overshoot and no need for calibration. Just one of the many ways Park NX-PTR saves you time and gives you better data.



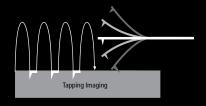
## **True Non-Contact™ Mode Preserves Sharp Tip**

AFM tips are so brittle that touching a sample will instantly reduce the resolution and quality of the image they produce. For soft and delicate samples, the tip will also damage the sample and result in inaccurate sample height measurements, something that can cost you valuable time and money.

True Non-Contact™ mode, a scan mode unique to Park AFMs, consistently produces high resolution and accurate data while maintaining the integrity of the sample.



#### Accurate Feedback by Faster Z-servo enables True Non-Contact AFM



#### **Tapping Imaging**

- Quick tip wear = Blurred low-resolution scan
- Destructive tip-sample interaction = Sample damage and modification
- Highly parameter-dependent



#### **True Non-Contact™ Mode**

- Less tip wear = Prolonged high-resolution scan
- Non-destructive tip-sample interaction = Minimized sample modification
- Immunity from parameter dependent results

## The most innovative AFM technology in one powerful package

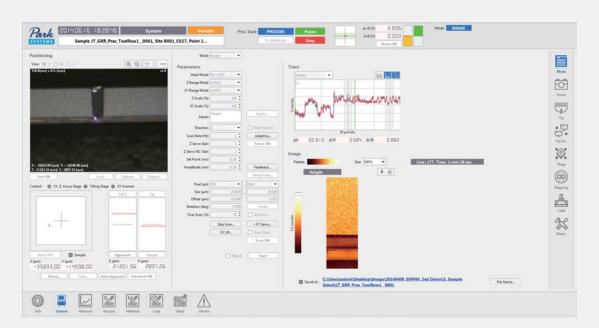
#### Low Noise XYZ Position Sensors for more accurate scans

The NX-PTR provides you with unprecedented accuracy in topography height measurement by utilizing its ultra-low noise Z detector instead of the commonly used Z voltage signal that is non-linear in nature. Industry leading low noise Z detector replace the applied Z voltage as the topography signal and make the forward and backward scan gap a negligible 0.15% of the scan range.

#### Minimal Thermal Drift and Hysteresis reduces tip drift

The body of the NX-PTR is designed to be extremely mechanically and thermally stable, minimizing thermal drift and giving you more precise measurements. A typical thermal drift rate is less than 100 nm/°C for the lateral direction and 200 nm/°C for the vertical direction.

#### Automatic Measurement Control so you can get accurate scans with less work



The NX-PTR is equipped with automated software that makes operation nearly effortless. Just select the desired measurement program to get precise multi-site analysis with optimized setting for cantilever tuning, scan rate, gain, and set point parameters.

Park's user-friendly software interface gives you the flexibility to create customized operation routines so you can access the full power of the NX-PTR and get the measurements you need.

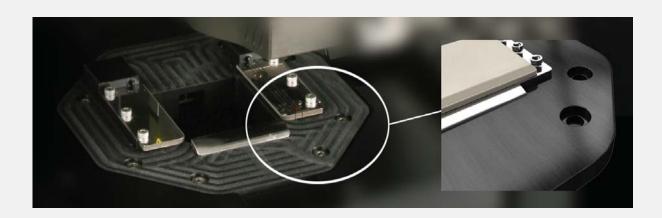
Creating new routines is easy. It takes about 10 minutes to create a new routine from scratch, or less than 5 minutes to modify an existing one.

#### Park NX-PTR's automated system features:

- Auto, semi-auto, and manual mode so you have complete control
- Editable measurement method for each automated routine
- Live monitoring of the measurement process
- Automatic analysis of acquired measurement data

#### **Options**

#### Customize your AFM to make it more efficient and more effective



#### **Customized Sample Fixture**

Park Systems can prepare customized sample fixtures to support customers' specific samples, row bars or individual sliders. The customized sample fixture can provide a better connection between the measuring sample and the NX-PTR for increased accuracy.

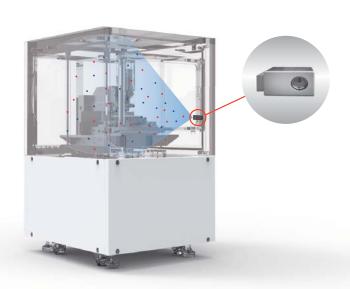


#### **Customized HGA Fixture**

HGA fixtures can be custom built to firmly fit a specific HGA design provided by the customer, offering a more stable fixture. The non-damaging fixture allows users to easily load and unload the entire HGA, without causing any damage to the HGA. HGA then can be dismounted, and further tested. Up to 5 HGA samples of the same type can be mounted at the same time.

## Ionization System for a more stable scanning environment

Our advanced ionization system quickly and effectively removes electrostatic charges in your sample's environment. Since the system always generates and maintains the ideal balance of positive and negative ions, it can create an extremely stable charge environment with little contamination of the surrounding area, and minimal risk of accidental electrostatic charge during sample handling.



## **Specification**

System Specification	Motorized XY stage	Motorized Z stage		
	travels up to 200 mm $\times$ 200 mm, $^{2}$	2 μm repeatability 25 mm Z travel distance 0.1 μm resolution, <1 μm repeatability		
Scanner Performances	XY Scanner Range	XY Scanner Resolution		
	100 μm × 100 μm	0.095 nm (20 bit position control)		
AFM and XY Stage Control Electronics	ADC	DAC		
	18 channels 4 high-speed ADC channels (64 M 24-bit ADCs for X,Y and Z scanner	- ·		
Vibration, Acoustic Noise	Floor Vibration	Floor Vibration		
	$<\!0.5\mu\text{m/s}$ (10 Hz to 200 Hz w/ Ad	$<\!0.5~\mu\text{m/s}~$ (10 Hz to 200 Hz w/ Active Vibration Isolation System)		
Facility Requirements	Room Temperature (Stand By)	Room Temperature (Operating) Humidity		
	10 °C ~ 40 °C	18 °C ~ 24 °C 30% to 60% (not condensing)		
Dimensions in mm & Weight in kg	Acoustic Enclosure	Control Cabinet		
	880 (w) $\times$ 980 (d) $\times$ 1460 (h) 620 kg approx. (incl. basic NX-PTR	600 (w) $\times$ 900 (d) $\times$ 1330 (h) System) 170 kg approx. (incl. controllers)		

15 mm Z travel distance for on-axis optics	tilt angle: ±1.8°	up to 20 mm	<2 nm over 80 μm	pattern align resolution of 1/4 pixel
Z Scanner Range	Z Scanner Resolution	Z Scanner Noise Floor		
15 µm	0.01 nm	<0.05 nm (w/ Active Vibration Isolation Sys	stem)	

Z run-out

Sample Thickness Allowance

#### Acoustic Noise

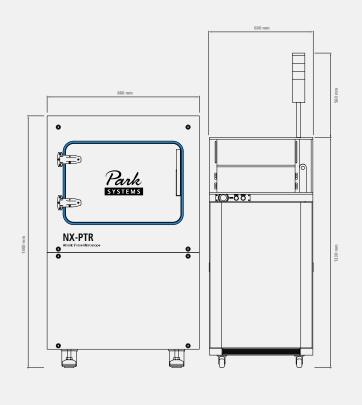
Motorized Focus Stage

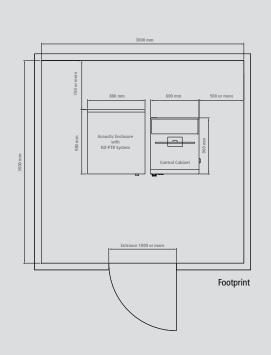
>20 dB attenuation w/ Acoustic Enclosure

Floor Vibration Level	Acoustic Noise	Pneumatics	Power Supply Rating	Total Power Consumption	Ground Resistance
VC-E (3 µm/sec)	Below 65 dB	Vacuum: -60 kPa	100/120 V/ 208~240 V, single phase, 15 A (max)	2 KW (typical)	Below 100 ohms

System Floor Space	Ceiling Height	Operator Working Space
1720 (w) × 920 (d)	2000 or more	2400 (w) × 2450 (d), minimum

Tilting stage

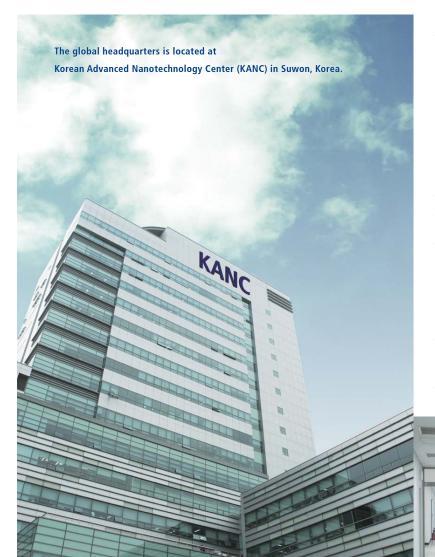




COGNEX Pattern Recognition

## **Park Systems**

## Dedicated to producing the most accurate and easiest to use AFMs



More than a quarter century ago, the foundations for Park Systems were laid at Stanford University where Dr. Sang-il Park, the founder of Park Systems worked as an integral part of the group that first developed AFM technology. After perfecting the technology, he then went on to create the first commercial AFM and later Park Systems was born.

Park Systems strives everyday to live up to the innovative spirit of its beginnings. Throughout our long history, we have honored our commitment to providing the most accurate and yet very easy to use AFMs, with revolutionary features like True Non-Contact™ mode, and many automated software tools. We are not simply content to rest on our past success. All of our products are designed with same care and creativity that went into our first, allowing you to focus on getting results without worrying about the integrity of your tools.

### www.parkAFM.com

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